

PC3H3 Series

*4-channel package type is also available. (model No. **PC3Q63**)

Mini-flat Half Pitch Package, High CMR, AC Input Photocoupler



■ Description

PC3H3 Series contains a IRED optically coupled to a phototransistor.

It is packaged in a 4-pin Mini-flat, Half pitch type.

Input-output isolation voltage(rms) is 2.5kV.

Collector-emitter voltage is 80V^(*) and CMR is MIN. 10kV/μs.

■ Features

1. 4-pin Mini-flat Half pitch package (Lead pitch : 1.27mm)
2. Double transfer mold package (Ideal for Flow Soldering)
3. AC input type
4. High collector-emitter voltage (V_{CEO} : 80V^(*))
5. High noise immunity due to high common mode rejection voltage (CMR : MIN. 10kV/μs)
6. Isolation voltage between input and output ($V_{iso(rms)}$: 2.5kV)

(*) Up to Date code "P9" (September 2002) V_{CEO} : 35V.
From the production Date code "J5" (May 1997) to "P9" (September 2002), however the products were screened by $BV_{CEO} \geq 70V$.

■ Agency approvals/Compliance

1. Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. **PC3H3**)
2. Package resin : UL flammability grade (94V-0)

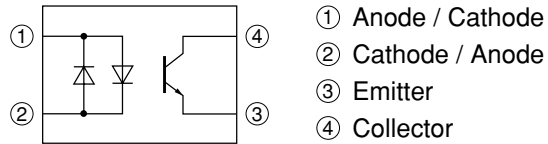
■ Applications

1. Programmable controllers

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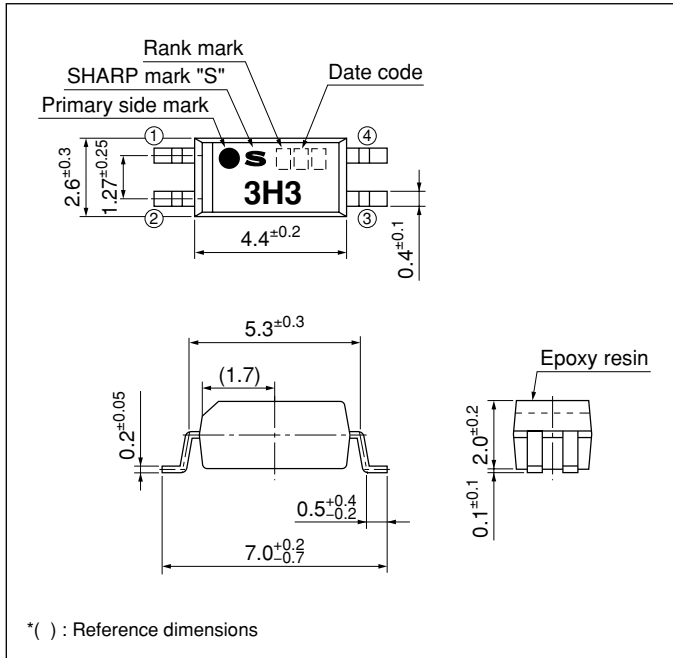
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Internal Connection Diagram



Outline Dimensions

(Unit : mm)



Product mass : approx. 0.05g

Date code (2 digit)

1st digit				2nd digit	
Year of production				Month of production	
A.D.	Mark	A.D.	Mark	Month	Mark
1990	A	2002	P	January	1
1991	B	2003	R	February	2
1992	C	2004	S	March	3
1993	D	2005	T	April	4
1994	E	2006	U	May	5
1995	F	2007	V	June	6
1996	H	2008	W	July	7
1997	J	2009	X	August	8
1998	K	2010	A	September	9
1999	L	2011	B	October	O
2000	M	2012	C	November	N
2001	N	∴	∴	December	D

repeats in a 20 year cycle

Country of origin

Japan

Rank mark

Refer to the Model Line-up table

■ Absolute Maximum Ratings (T_a=25°C)

	Parameter	Symbol	Rating	Unit
Input	Forward current	I _F	±50	mA
	*1 Peak forward current	I _{FM}	±1	A
	Power dissipation	P	70	mW
Output	Collector-emitter voltage	V _{CEO}	*4 80	V
	Emitter-collector voltage	V _{ECO}	6	V
	Collector current	I _C	50	mA
	Collector power dissipation	P _C	150	mW
	Total power dissipation	P _{tot}	170	mW
	Operating temperature	T _{opr}	−30 to +100	°C
	Storage temperature	T _{stg}	−40 to +125	°C
	*2 Isolation voltage	V _{iso (rms)}	2.5	kV
	*3 Soldering temperature	T _{sol}	260	°C

*1 Pulse width ≤ 100μs, Duty ratio : 0.001

*2 40 to 60%RH, AC for 1 minute, f=60Hz

*3 For 10s

*4 Up to Date code "P9" (September 2002) V_{CEO} : 35V.

■ Electro-optical Characteristics (T_a=25°C)

	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	V _F	I _F =±20mA	–	1.2	1.4	V
	Terminal capacitance	C _t	V=0, f=1kHz	–	30	250	pF
Output	Collector dark current	I _{CEO}	V _{CE} =50V, I _F =0	–	–	100	nA
	Collector-emitter breakdown voltage	BV _{CEO}	I _C =0.1mA, I _F =0	*5 80	–	–	V
	Emitter-collector breakdown voltage	BV _{ECO}	I _E =10μA, I _F =0	6	–	–	V
Transfer characteristics	Collector current	I _C	I _F =±1mA, V _{CE} =5V	0.2	–	4.0	mA
	Collector-emitter saturation voltage	V _{CE (sat)}	I _F =±20mA, I _C =1mA	–	0.1	0.2	V
	Isolation resistance	R _{ISO}	DC500V, 40 to 60%RH	5×10 ¹⁰	1×10 ¹¹	–	Ω
	Floating capacitance	C _f	V=0, f=1MHz	–	0.6	1.0	pF
	Response time	Rise time	V _{CE} =2V, I _C =2mA, R _L =100Ω	–	4	18	μs
		Fall time		–	3	18	μs
	Common mode rejection voltage	CMR	T _a =25°C, R _L =470Ω, V _{CM} =1.5kV(peak), I _F =0, V _{CC} =9V, V _{np} =100mV	10	–	–	kV/μs

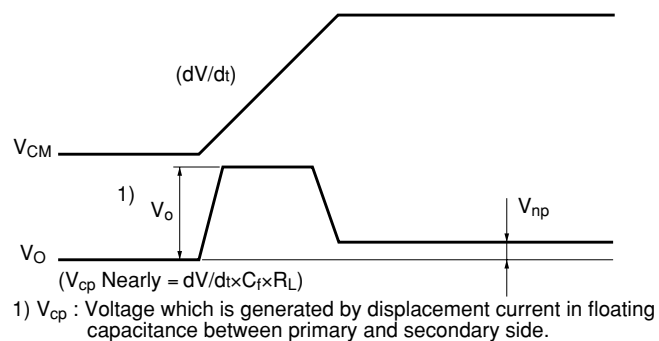
*5 From the production Date code "J5" (May 1997) to "P9" (September 2002), however the products were screened by BV_{CEO} ≥ 70V.

■ Model Line-up

Package	Taping	Rank mark	I _C [mA] (I _F =±1mA, V _{CE} =5V, T _a =25°C)
	3 000pcs/reel		
Model No.	PC3H3	with or without	0.2 to 4.0
	PC3H3A	A	0.5 to 1.5
	PC3H3B	B	1.0 to 2.5

Please contact a local SHARP sales representative to inquire about production status and Lead-Free options.

V_{CM} : High wave pulse
 $R_L = 470\Omega$
 $V_{CC} = 9V$



The graph shows the forward current I_F (mA) as a function of ambient temperature T_a (°C). The current is constant at 50 mA for temperatures from -30°C to 55°C. Between 55°C and 100°C, the current decreases linearly to 18 mA. At 110°C, the current drops to 0 mA.

Ambient temperature T_a (°C)	Forward current I_F (mA)
-30	50
55	50
100	18
110	0

The graph shows the relationship between diode power dissipation and ambient temperature. The y-axis represents Diode power dissipation P in mW, ranging from 0 to 100. The x-axis represents Ambient temperature T_a in $^{\circ}\text{C}$, ranging from -30 to 125. The power is constant at 70 mW for temperatures up to 55°C. Beyond 55°C, the power decreases linearly, reaching 25 mW at 100°C. For temperatures above 100°C, the power is zero.

Ambient temperature T_a ($^{\circ}\text{C}$)	Diode power dissipation P (mW)
-30	70
55	70
100	25
125	0

The graph shows the relationship between Collector power dissipation P_C (mW) and Ambient temperature T_a (°C). The power dissipation is constant at 150 mW for temperatures from -30°C to 25°C. Beyond 25°C, the power dissipation decreases linearly, reaching 40 mW at 100°C. At 100°C, the power dissipation drops to 0 mW.

Ambient temperature T_a (°C)	Collector power dissipation P_C (mW)
-30	150
0	150
25	150
50	115
75	80
100	40
100	0

The graph shows the total power dissipation P_{tot} in mW as a function of ambient temperature T_a in $^{\circ}\text{C}$. The power is constant at 170 mW for temperatures from -30°C to 25°C. Beyond 25°C, the power decreases linearly, reaching 40 mW at 100°C. At 105°C, the power drops to 0 mW, indicating the maximum operating temperature.

Ambient temperature T_a ($^{\circ}\text{C}$)	Total power dissipation P_{tot} (mW)
-30	170
25	170
100	40
105	0

Fig.6 Peak Forward Current vs. Duty Ratio

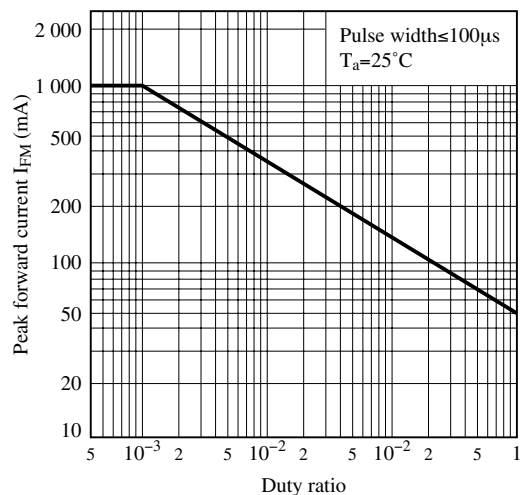


Fig.7 Forward Current vs. Forward Voltage

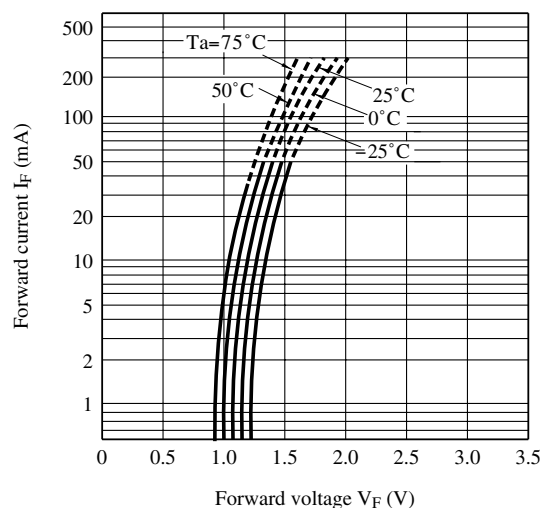


Fig.8 Current Transfer Ratio vs. Forward Current

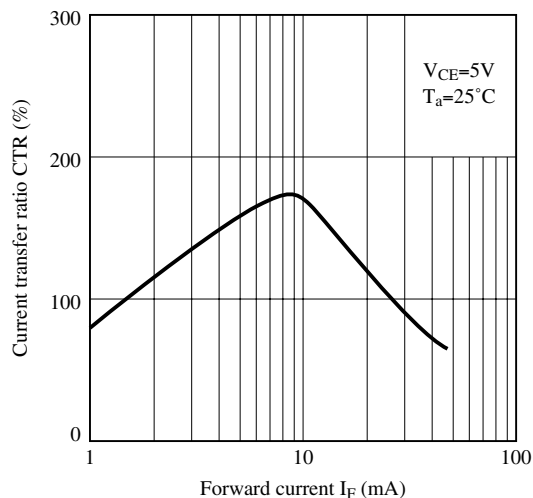


Fig.9 Collector Current vs. Collector-emitter Voltage

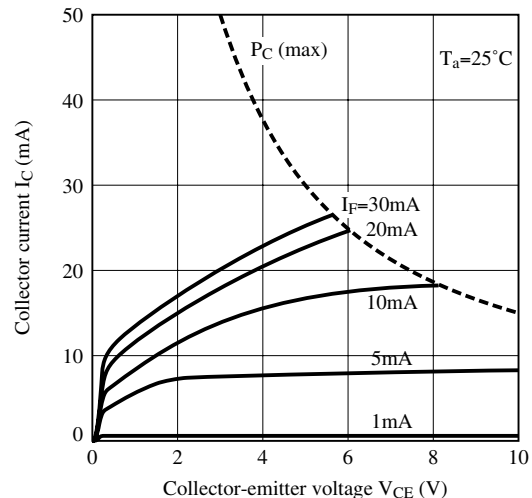


Fig.10 Relative Current Transfer Ratio vs. Ambient Temperature

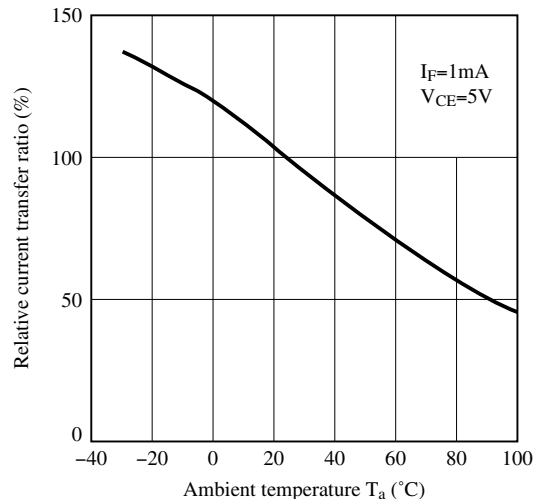


Fig.11 Collector - emitter Saturation Voltage vs. Ambient Temperature

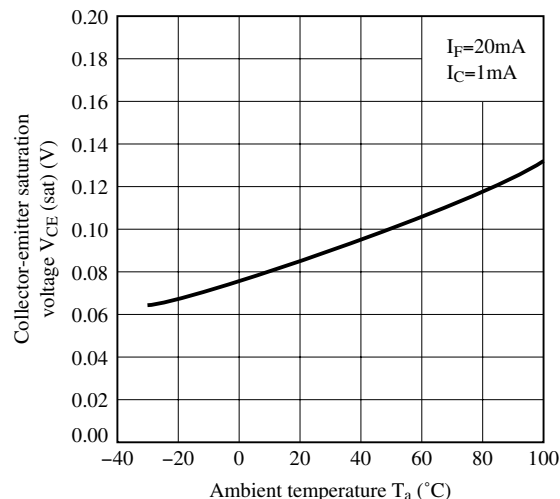


Fig.12 Collector Dark Current vs. Ambient Temperature

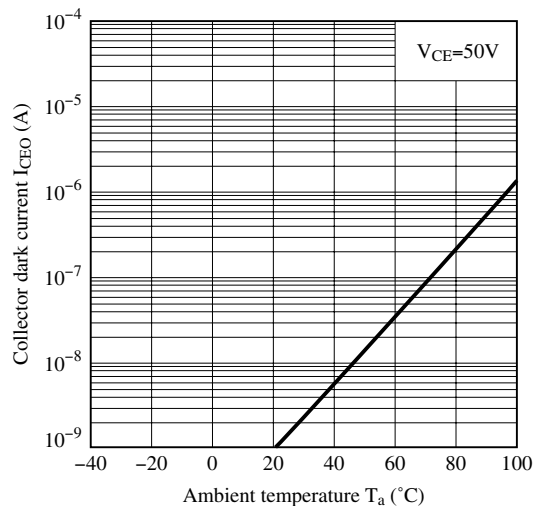


Fig.13 Response Time vs. Load Resistance

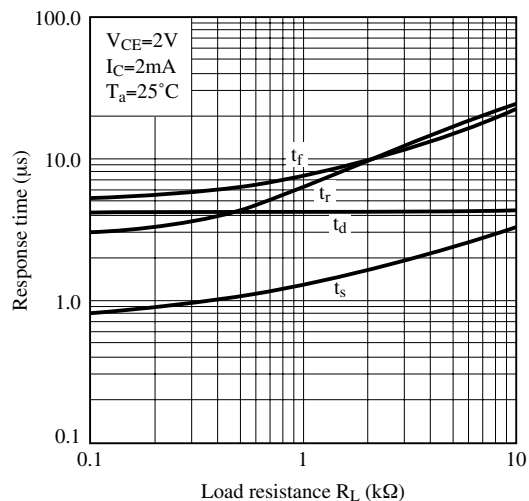
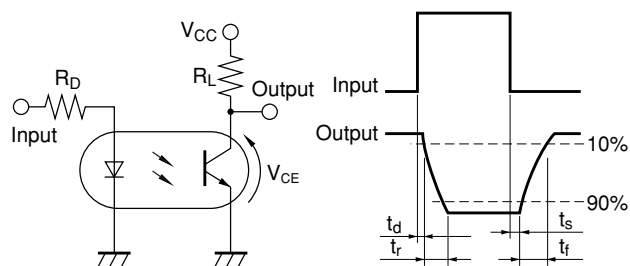


Fig.14 Test Circuit for Response Time



Please refer to the conditions in Fig.13

Fig.15 Frequency Response

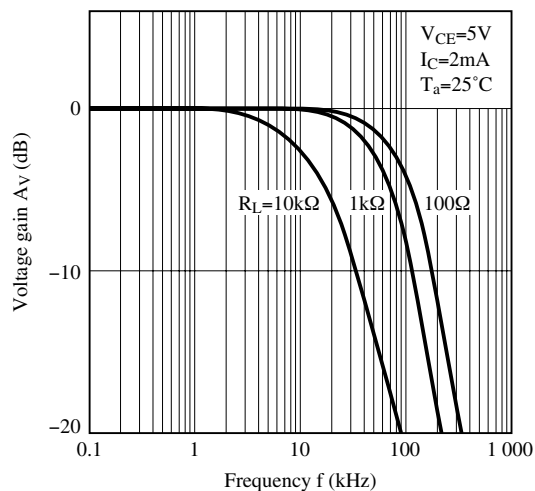
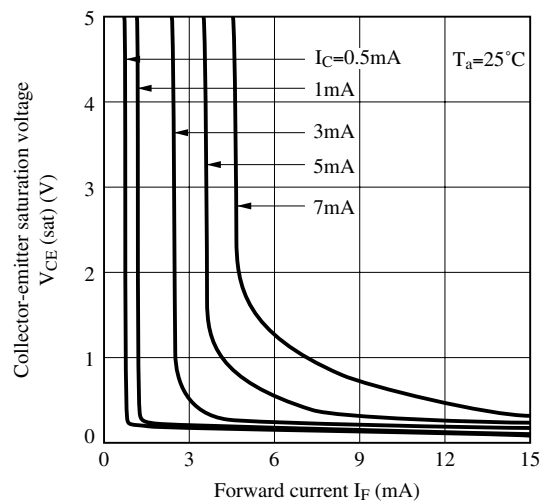


Fig.16 Collector-emitter Saturation Voltage vs. Forward Current



Remarks : Please be aware that all data in the graph are just for reference and not for guarantee.

■ Design Considerations

● Design guide

While operating at $I_F < 1.0\text{mA}$, CTR variation may increase.
Please make design considering this fact.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through IRED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of IRED.

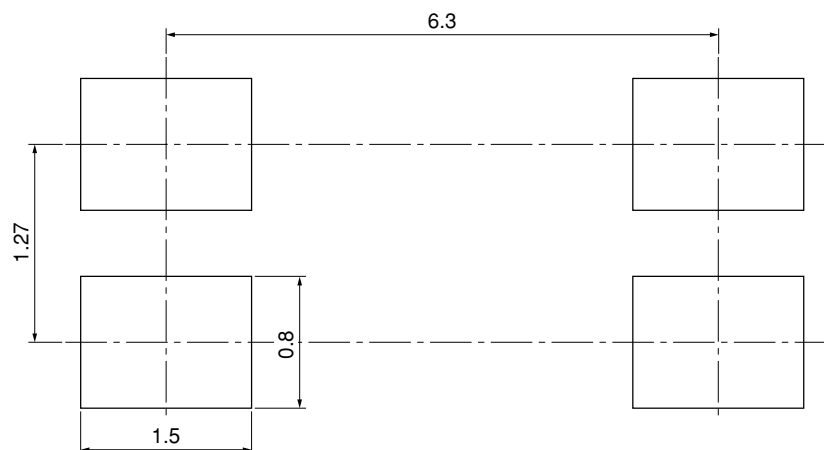
This product is not designed against irradiation and incorporates non-coherent IRED.

● Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5years) into the design consideration.

● Recommended Foot Print (reference)



(Unit : mm)

■ Manufacturing Guidelines

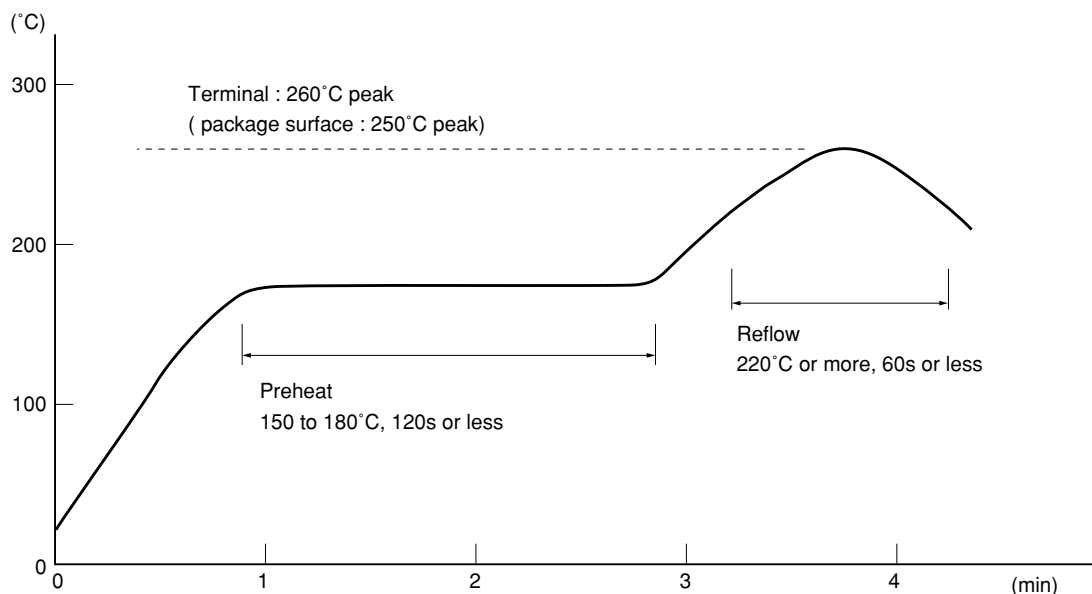
● Soldering Method

Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.

Soldering should not exceed the curve of temperature profile and time.

Please don't solder more than twice.



Flow Soldering :

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 260°C and within 10s.

Preheating is within the bounds of 100 to 150°C and 30 to 80s.

Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C.

Please don't solder more than twice.

Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.

● Cleaning instructions**Solvent cleaning:**

Solvent temperature should be 45°C or below Immersion time should be 3minutes or less

Ultrasonic cleaning:

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials:

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

● Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this device.

Regulation substances:CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

■ Package specification

● Tape and Reel package

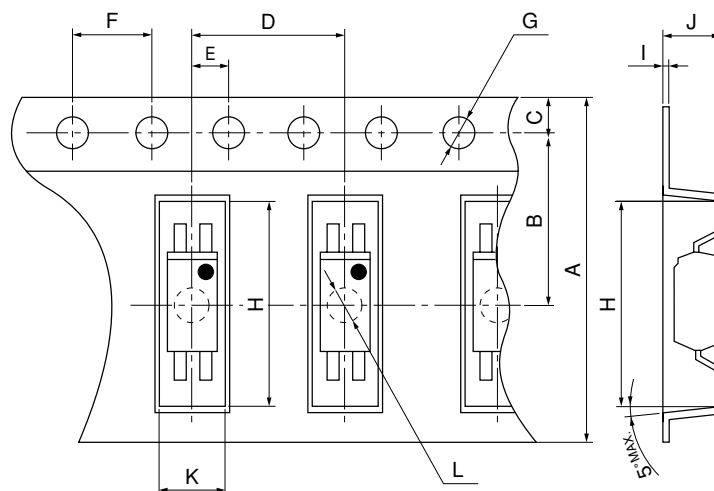
Package materials

Carrier tape : PS

Cover tape : PET (three layer system)

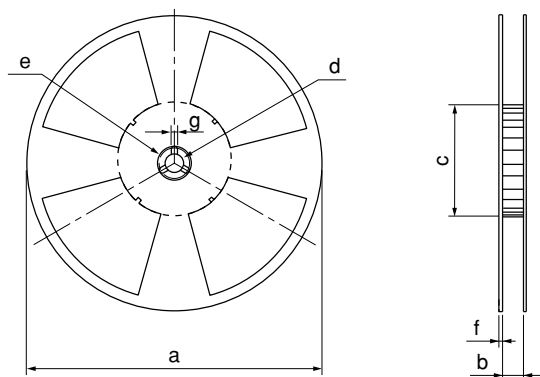
Reel : PS

Carrier tape structure and Dimensions



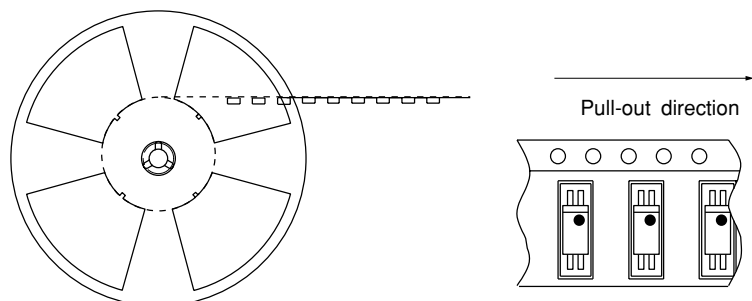
Dimensions List (Unit : mm)						
A	B	C	D	E	F	G
12.0 \pm 0.3	5.5 \pm 0.1	1.75 \pm 0.1	8.0 \pm 0.1	2.0 \pm 0.1	4.0 \pm 0.1	ϕ 1.5 $^{+0.1}_{-0}$
H	I	J	K	L		
7.5 \pm 0.1	0.3 \pm 0.05	2.3 \pm 0.1	3.1 \pm 0.1	ϕ 1.6 $^{+0.1}_{-0}$		

Reel structure and Dimensions



Dimensions List (Unit : mm)			
a	b	c	d
330	13.5 \pm 1.5	100 \pm 1.0	13 \pm 0.5
e	f	g	
23 \pm 1.0	2.0 \pm 0.5	2.0 \pm 0.5	

Direction of product insertion



[Packing : 3 000pcs/reel]

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- Personal computers
- Office automation equipment
- Telecommunication equipment [terminal]
- Test and measurement equipment
- Industrial control
- Audio visual equipment
- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection

with equipment that requires higher reliability such as:

- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- Traffic signals
- Gas leakage sensor breakers
- Alarm equipment
- Various safety devices, etc.

(iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:

- Space applications
- Telecommunication equipment [trunk lines]
- Nuclear power control equipment
- Medical and other life support equipment (e.g., scuba).

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